TOSHIBA Field Effect Transistor Silicon P-Channel MOS Type (U-MOS IV)

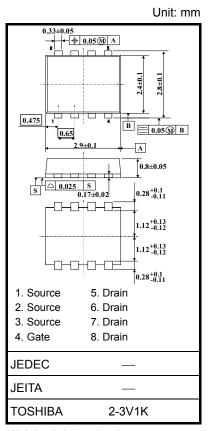
TPCP8102

Notebook PC Applications Portable Equipment Applications

- · Small footprint due to small and thin package
- Low drain-source ON-resistance: RDS (ON) = $13.5 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 24 \text{ S (typ.)}$
- Low leakage current: $I_{\rm DSS}$ = -10 μA (max) (V_{\rm DS} = -20 V)
- Enhancement model: V_{th} = -0.45 to -1.2 V (V_{DS} = -10 V, I_D = -200 μA)

Absolute Maximum Ratings (Ta = 25°C)

Characteristic			Symbol	Rating	Unit	
Drain-source voltage			V_{DSS}	-20	V	
Drain-gate voltage (R	GS = 20	kΩ)	V_{DGR}	-20	V	
Gate-source voltage			V _{GSS}	± 12	V	
Drain current	DC	(Note 1)	I _D	-7.2	Α	
Drain current	Pulse	(Note 1)	I _{DP}	-28.8	A	
Drain power dissipation	on	(t = 5 s) (Note 2a)	P_{D}	1.68	W	
Drain power dissipation	on	(t = 5 s) (Note 2b)	P_{D}	0.84	W	
Single-pulse avalanch	ne energ	y(Note 3)	E _{AS}	33.7	mJ	
Avalanche current			I _{AR}	-7.2	Α	
Repetitive avalanche	energy	(Note 4)	E _{AR}	0.168	mJ	
Channel temperature			T _{ch}	150	°C	
Storage temperature	range		T _{stg}	-55~150	°C	



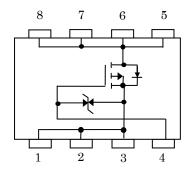
Weight: 0.017 g (typ.)

Note: For Notes 1 to 5, refer to the next page.

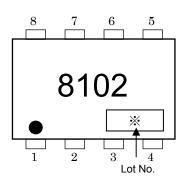
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

Circuit Configuration



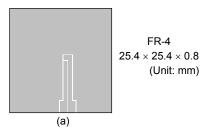
Marking (Note 5)

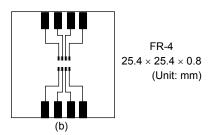


Thermal Characteristics

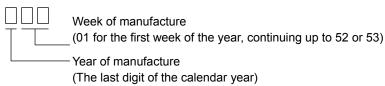
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 5 s) (Note 2a)	R _{th (ch-a)}	74.4	°C/W
Thermal resistance, channel to ambient (t = 5 s) (Note 2b)	R _{th (ch-a)}	148.8	°C/W

- Note 1: Ensure that the channel temperature does not exceed 150°C during use of the device.
- Note 2: (a) Device mounted on a glass-epoxy board (a)
- (b) Device mounted on a glass-epoxy board (b)





- Note 3: $V_{DD} =$ -16 V, $T_{ch} = 25^{\circ}C$ (initial), L = 0.5 mH, $R_{G} = 25~\Omega$, $I_{AR} =$ -7.2 A
- Note 4: Repetitive rating: pulse width limited by maximum channel temperature.
- Note 5: on the lower left of the marking indicates Pin 1.
 - * Weekly code (three digits):



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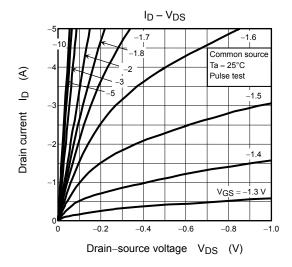
Electrical Characteristics (Ta = 25°C)

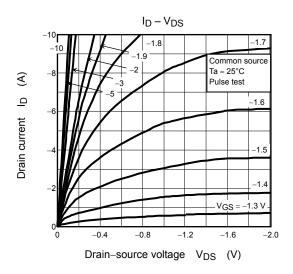
Cha	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS} = \pm 10 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cutoff curre	ent	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$		_	-10	μА
Drain-source bre	akdown voltage	V _{(BR) DSS}	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-20		_	V
Diam-source bre	akdown voltage	V _{(BR) DSX}	$I_D = -10 \text{ mA}, V_{GS} = 12 \text{ V}$	-8		_	V
Gate threshold vo	oltage	V _{th}	$V_{DS} = -10 \text{ V}, I_D = -200 \mu\text{A}$	-0.45	_	-1.2	V
			V _{GS} = -2.0 V, I _D = -1.8 A	_	29	80	
Drain-source ON-resistance		R _{DS} (ON)	V _{GS} = -2.5 V, I _D = -3.6 A	_	20	30	mΩ
			V _{GS} = -4.5 V, I _D = -3.6 A	_	13.5	18	
Forward transfer admittance		Y _{fs}	$V_{DS} = -10 \text{ V}, I_D = -3.6 \text{ A}$	12	24	_	S
Input capacitance		C _{iss}		_	2560	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	330	_	
•		Coss		_	380	_	
	Rise time	t _r	V _{GS} 0 V 7	_	5	_	
	_	14	_				
	Fall time	t _f	4.7 S	_	42	_	ns
	Turn-off time	t _{off}		_	142	_	
		Qg	Vpp ~ -16 V Vcs = -5 V	_	33		_
Gate-source charge 1		Q _{gs1}		_	5.4	_	nC
Gate-drain ("Mille	er") charge	Q _{gd}		_	10	_	

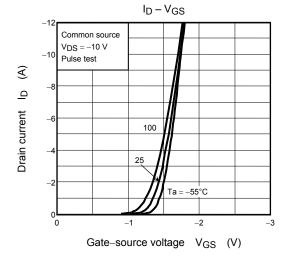
Source-Drain Ratings and Characteristics (Ta = 25°C)

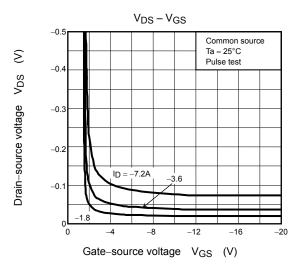
Charac	teristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_			-28.8	Α
Forward voltage	(diode)	V_{DSF}	o _R = -3.6 A, V _{GS} = 0 V — — 1.2		V		

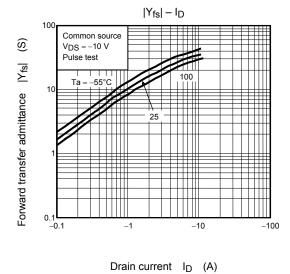
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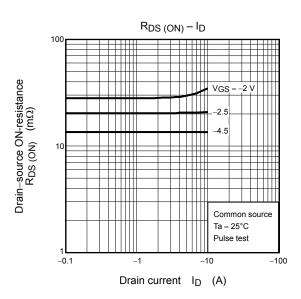




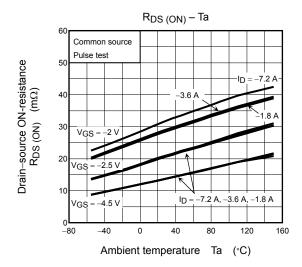


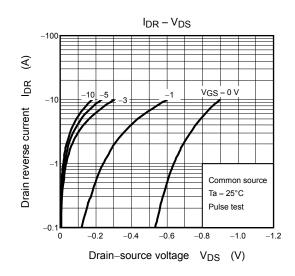


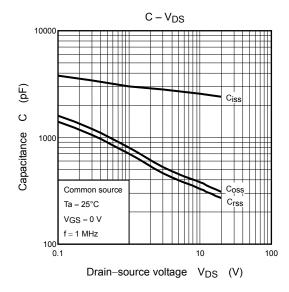


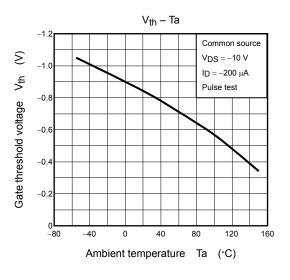


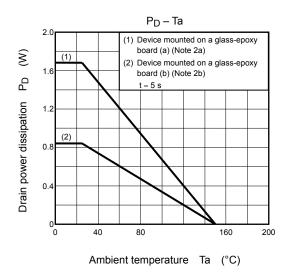
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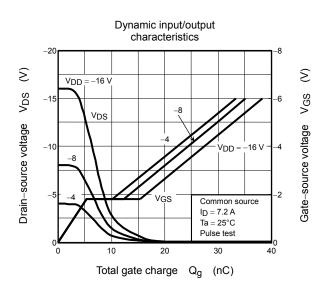


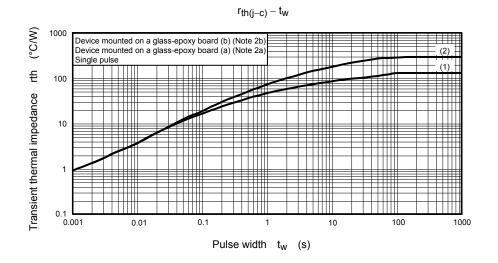


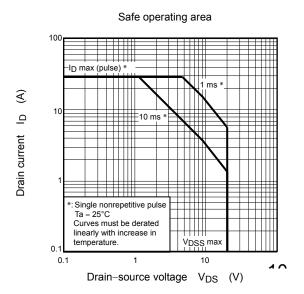












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